

RELIABILITY REPORT

FOR

MAX40056FAUA+
MAX40056FAUA+T

September 24, 2020

MAXIM INTEGRATED

160 RIO ROBLES
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Conclusion

The MAX40056F successfully meets the quality and reliability standards required of all Maxim Integrated products. In addition, Maxim Integrated's continuous reliability monitoring program ensures that all outgoing product will continue to meet Maxim Integrated's quality and reliability standards.

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I. Device Description

A. General

The MAX40056 is a bidirectional current-sense amplifier with an input common-mode range that extends from -0.1V to +65V together with protection against negative inductive kickback voltages to -5V. This CSA is well-suited for phase current monitoring of inductive loads, such as motors and solenoids, where pulse width modulation is used to control the drive voltage and current. The MAX40056 uses an improved technique to help reject common-mode input PWM edges with slew rates up to and beyond $\pm 500\text{V}/\mu\text{s}$. Common mode rejection ratio (CMRR) is typically 60dB (50V, $\pm 500\text{V}/\mu\text{s}$ input) and 140dB DC, typical.

The MAX40056 has an internal +1.5V reference for use with a nominal +3.3V power supply. The reference can also be used to drive an adjoining differential ADC. The reference is used to offset the output to indicate the direction of the input sensed current. The REF pin can source current into external loads and helps to avoid the performance compromises resulting from routing reference voltages across noisy PCBs. Alternatively, for higher supply voltages and higher full-scale output swings, the internal reference can be overridden by a higher voltage, external reference.

The internal or external reference can be used to define the trip threshold for the integrated overcurrent comparator. This can provide immediate indication of an overcurrent fault condition.

The MAX40056 operates over the full -40°C to +125°C temperature range and runs from a supply voltage of +2.7V to +5.5V. It is offered in a 2.02mm x 1.4mm 8-pin wafer-level package (WLP) and 8-pin μMAX packages.

II. Manufacturing Information

A. Description/Function:	Bidirectional Current Sense Amplifier with PWM-Rejection
B. Process:	S18
C. Device Count:	12856
D. Fabrication Location:	Japan
E. Assembly Location:	Thailand
F. Date of Initial Production:	September 2018

III. Packaging Information

A. Package Type:	uMAX
B. Lead Frame:	Cu7025
C. Lead Finish:	Matte Tin
D. Die Attach:	84-1LMISR4
E. Bondwire:	1 mil Au
F. Mold Material:	G600
G. Assembly Diagram:	05-100988
H. Flammability Rating:	UL-94 (V-0 Rating)
I. Classification of Moisture Sensitivity per JEDEC standard J-STD-020-C	Level 1
J. Single Layer Theta Ja:	N/A
K. Single Layer Theta Jc:	N/A
L. Multi Layer Theta Ja:	206 °C/W
M. Multi Layer Theta Jc:	42 °C/W

IV. Die Information

A. Dimensions:	80.7086X56.299 mils
B. Passivation:	SiN/SiO2

V. Quality Assurance Information

A. Quality Assurance Contacts:	Ryan Wall (Manager, Reliability) Michael Cairnes (Executive Director, Reliability) Bryan Preeshl (SVP of QA)
B. Outgoing Inspection Level:	0.1% for all electrical parameters guaranteed by the Datasheet. 0.1% for all Visual Defects.
C. Observed Outgoing Defect Rate:	< 50 ppm
D. Sampling Plan:	Mil-Std-105D

VI. Reliability Evaluation

A. Accelerated Life Test

The results of the 125C biased (static) life test are shown in Table 1. Using these results, the Failure Rate λ is calculated as follows:

$$\lambda = \frac{1}{MTTF} = \frac{1.83}{192 \times 2454 \times 79 \times 2} \text{ (Chi square value for MTTF upper limit)}$$

(where 2454 = Temperature Acceleration factor assuming an activation energy of 0.8eV)

$$\lambda = 24.61 \times 10^{-9}$$

$$\lambda = 24.61 \text{ FITs (60\% confidence level @25°C)}$$

Maxim Integrated performs quarterly life test monitors on its processes. This data is published in the Reliability Report found at <https://www.maximintegrated.com/en/support/qa-reliability/reliability/reliability-monitor-program.html>.

S18 cumulative process Fit

$$\lambda = 0.02 \text{ FITs (60\% confidence level @25°C)}$$

$$\lambda = 0.24 \text{ FITs (60\% confidence level @55°C)}$$

B. ESD and Latch-Up Testing

The MAX40056F has been found to have all pins able to withstand an HBM transient pulse of ± 2500 V per JEDEC / ESDA JS-001. Latch-Up testing has shown that this device withstands ± 100 mA current injection and supply overvoltage per JEDEC JESD78.

Table 1
Reliability Evaluation Test Results
MAX40056FAUA/V+

TEST ITEM	TEST CONDITION	FAILURE IDENTIFICATION	SAMPLE SIZE	NUMBER OF FAILURES	COMMENTS
Static Life Test (Note 1)	Ta = 125°C Biased Time = 192 hrs.	DC parameters & functionality	79	0	

Note 1: Life Test Data may represent plastic DIP qualification lots.